Chapter 1- 4: Embedded Computing

Soo-Ik Chae

High Performance Embedded Computing © 2007 Elsevier

Topics

- Reliability, safety, and security.
- Consumer electronics.

Related disciplines

- Reliable/dependable system design creates systems that function even in the face of internal or external errors.
- Security concentrates on malicious attacks.
- Safety-critical system design develops methods to ensure that systems operate safely under a wide variety of error conditions.

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Dependability	y and securit	y
1 .		
continuity Reliability	Availability	
-	Availability Integrity	Confidentiality

After Avizienis et al. [Avi04]

Attributes of dependability and security (Avizienis et al.)

- Availability of correct service.
- Continuity of correct service.
- Safety from catastrophic consequences.
- Integrity from improper system alterations.
- Maintainability through modification or repairs.

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Confidentiality of information.

Reliability requirements on embedded

systems

- Safety-critical or high-reliability applications:
 - Automotive.
 - Aviation.
 - Medicine.
 - Critical communications.
- Many high-reliability applications require distributed embedded systems.
- Embedded systems may be vulnerable to new types of attacks.

Faults

- Faults may cause errors; reliable systems recover from faults.
- A fault may be transient or permanent.
- Types of faults:
 - Physical faults from manufacturing defects, radiation hazards, etc.
 - Design faults.
 - Operational faults from human error, security breaches, etc.

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System reliability metrics

- Mean time to failure (MTTF) is the expected time for first system to fail:
- Reliability function describes the probability that the system will operate correctly in the time interval [0,t].
- Hazard function is the failure rate of components:

$$MTTF \stackrel{?}{=} \int_{0}^{\infty} R(t) dt$$

$$z(t) = \frac{pdf}{1 - CDF}$$

System reliability metrics

- pdf f(x)= θe^{-θx} where x ≥ 0 and θ > 0 is a constant
- cdf F(x)= P(X≤x) = 1- e^{-θx}
- Reliability = 1 F(x) = e^{-θx}
- Failure Rate = θ
- MTBF or MTTF = $1/\theta$ =
- Where the reliability of the component at x, R(x), is equal to the probability that the process or component performs its designed use at (time) x.

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Common fault distributions

- Exponential distribution.
- Weibull distribution.
- Bathtub distributions

Exponential distribution

- Hazard function
- PDF

 $h(t) = \lambda$ $f(t) = \lambda e^{-\lambda t}$

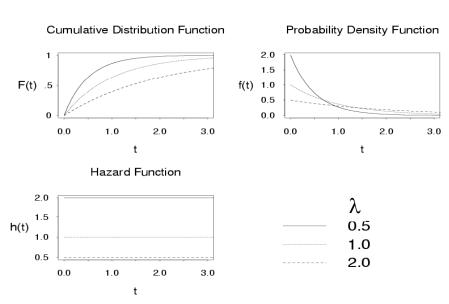
Survival function

$$P(T > t) = S(t) = \int_{t}^{\infty} h e^{-hu} du = -e^{-hu} \Big|_{t}^{\infty} = 0 - -e^{-ht} = e^{-ht}$$

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f(t), F(t), S(t), and h(t) for different exponential distributions:



Examples of Exponential Distributions

Weibull distribution

- The Weibull distribution is unique in that it takes on the shape which best fits the data. The more typical situation is where data is "force fitted" into a standard type of distribution, such as the Normal, Exponential, or other.
- For example, a Weibull shape factor of 1.00 represents an exponential distribution.
- A Weibull shape factor of about 3.25 or above represents an approximately normal distribution.
- In addition, use of any of the Weibull analysis routines to accomplish estimates of population characteristics, is simply a recognition of the fact that populations are rarely 100% normal, binomial, or exponential and so On.

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Weibull distribution

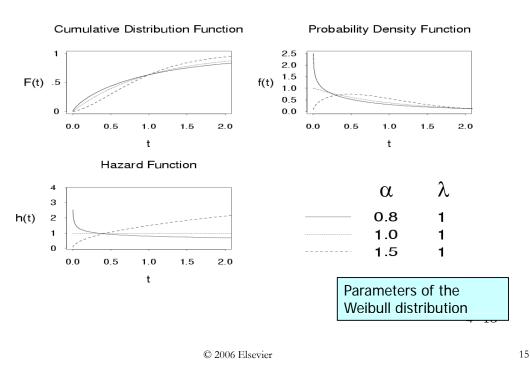
- Hazard function
 - Shape parameter: α
 - Scaling parameter: λ
- PDF
- Survival function

$$h(t) = \alpha \lambda (\lambda t)^{\alpha - 1}$$

$$f(t) = \alpha \lambda (\lambda t)^{\alpha - 1} e^{-(\lambda t)^{\alpha}}$$

$$P(T > t) = S(t) = \int_{e^{-(\lambda t)^{\alpha}}}^{\infty} e^{-u} du = e^{-(\lambda t)^{\alpha}}$$

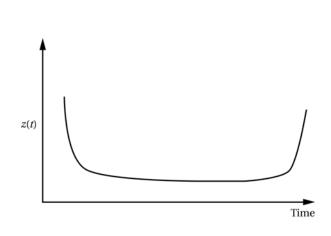
f(t), F(t), S(t), and h(t) for different Weibull distributions:



Examples of Weibull Distributions

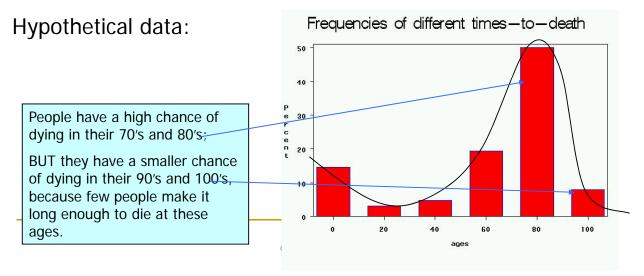
Bathtub distributions

- Bathtub distributions are often empirically observed.
 - High failure rates at beginning, end of component life.

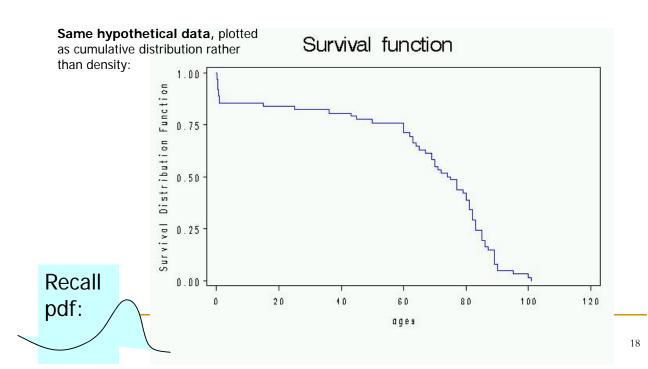


(Death) Probability density function: f(t)

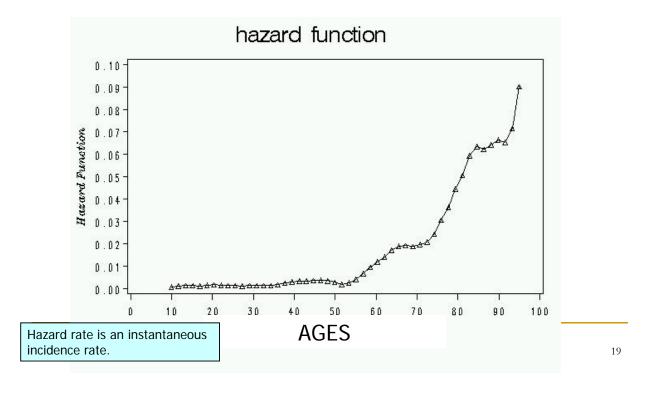
In the case of human longevity, T_i is unlikely to follow a normal distribution, because the probability of death is not highest in the middle ages, but at the beginning and end of life.



Cumulative survival



Hazard Function



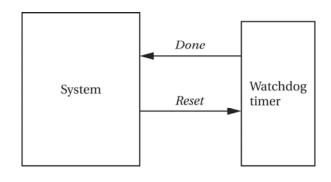
Possible actions after a fault

- Fail: without trying to even detect an error
- Detect: diagnostic information is useful even if the system stops
- Correct: memory errors are routinely corrected
- Recover: more than a simple correction which may cause a noticeable pause in system operation.
- Contain: steps to ensure that a failure does not corrupt a large part of the system
- Reconfigure: disable a faulty unit and enable another unit
- Restart: good for transient errors and software errors
- Repair: for either HW or SW components

Reliability methods

- Error-correction codes.
- Voting systems.
 - Triple-modular redundancy (TMR) uses majority voting.
- Watchdog timer must be periodically reset by system to show that system operates correctly.
- Design diversity uses redundancy implemented in different types of components.

- A done signal should be attached to an error interrupt in the system
- When running properly, it always resets the timer before it roll over.



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Novel attacks and countermeasures

- Embedded systems provide physical access, a key avenue for attack.
- Internet-enabled embedded systems provide remote access to attackers.
 - Example: Internet-enabled automobiles.
- Battery attacks exercise the system to wear out a battery.
- Quality-of-service attacks interfere with realtime behavior.

Sensor network attacks (Wood and Stankovic)

- Physical layer: jamming, tampering.
- Link layer: collision, exhaustion, unfairness.
- Network and routing layers: neglect and greed, horning, misdirection, authorization, probing, redundancy.
- Transport layer: flooding, desynchronization.

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Power attack

- Developed by Kocher et al.
- Measure CPU current to determine instructions, data.
 - Simple power analysis: inspect a trace manually to determine program action.
 - Differential power analysis: uses correlation to identify action and key bits. It was originally aimed at smart cards, which draw their power form the external card reader.
- High-leakage devices are less vulnerable to power attacks.

Consumer electronics architectures

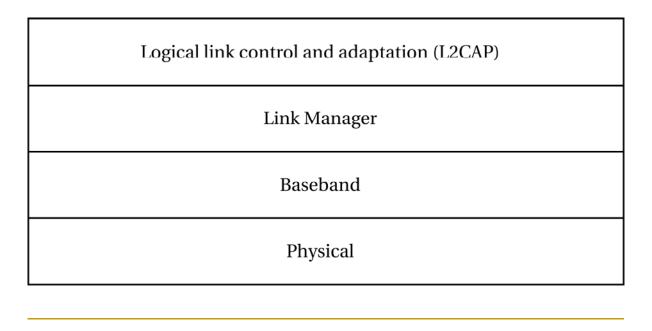
- Consumer electronics pushes the edge of the envelope in several directions:
 - Complex functionality and high performance.
 - Often battery-powered.
 - Very low cost.
- Generally include one or more standards.

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Bluetooth

- Personal-area network.
 - □ 2.5 GHz band.
 - Generally within 2 meters, may be extended to 30 meters.
- Basic network is master-slave, but higher levels of protocol stack provide peer-to-peer operation.

Bluetooth stack



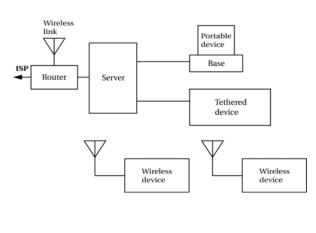
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Bluetooth middleware group protocols

- RFCOMM provides serial interface; compatible with RS-232.
- Service discovery protocol discovers services (printing, etc.) on the network.

Networked consumer appliances

- PC acts as a host.
- Some devices are semipermanently connected (USB); others are on wired Ethernet; others are on wireless networks.
- Devices must be configured properly with the system.



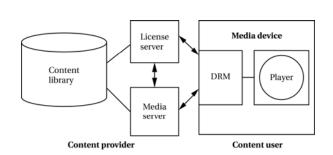
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High-level services

- Service discovery allows the device to find another device on the network that will provide a service (for example, printing).
 - Jini lookup services hold service proxies.
 - Jini uses join protocol to add a service.
 - □ Jini client obtains a lease for a given service.

Digital rights management

- Digital rights management (DRM) is used to ensure that copyrighted material is used within the terms required by owner.
 - Devices that can play material.
 - Number of times material can be played.
 - Expiration date.



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System overview : typical DRM model

